# Photocatalytic decomposition of NO on titanium oxide thin film photocatalysts prepared by an ionized cluster beam technique

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Transparent  $TiO_2$  thin film photocatalysts were prepared on transparent porous Vycor glass (PVG) by an ionized cluster beam (ICB) method. The UV-VIS absorption spectra of these films show specific interference fringes, indicating that uniform and transparent  $TiO_2$  thin films are formed. The results of XRD measurements indicate that these  $TiO_2$  thin films consist of both anatase and rutile structures. UV light ( $\lambda > 270$  nm) irradiation of these  $TiO_2$  thin films in the presence of NO led to the photocatalytic decomposition of NO into  $N_2$ ,  $N_2$  and  $N_2$ 0. The reactivity of these  $TiO_2$  thin films for the photocatalytic decomposition of NO is strongly dependent on the film thickness, i.e., the thinner the  $TiO_2$  thin films, the higher the reactivity.

Keywords: TiO<sub>2</sub> thin film photocatalyst, ionized cluster beam deposition method, ion engineering technique, decomposition reaction of NO

### 1. Introduction

 ${
m TiO_2}$  thin film photocatalysts prepared by the sol–gel method have been utilized in many fields not only due to its photocatalytic reactivity but also because of its useful antibacterial and superhydrophilic properties [1–4]. However, the sol–gel method of preparing  ${
m TiO_2}$  thin film photocatalysts is a wet process in itself, necessitating the use of solvents and calcination treatments at high temperature. It is therefore important to develop  ${
m TiO_2}$  thin films which show high photocatalytic performance and have high mechanical and physical stability when supported on various substrates in any desired form at a low cost.

In this study, we have studied the possibility of applying an advanced ionized cluster beam (ICB) method as an effective dry process in the design of highly reactive TiO<sub>2</sub> thin film photocatalysts. The general advantages of the ICB method [5] are: (1) contamination with various impurities can be easily prevented since the process is performed in a high vacuum chamber; (2) high crystallinity TiO<sub>2</sub> films can be prepared without calcination at high temperatures; and (3) the various physical and chemical properties of the thin films, such as the thickness, can be controlled and it can be applied on various substrates, even on substrates having little resistance to heat. Along these lines, TiO2 thin film photocatalysts have been prepared by applying such an ICB method and their physical and chemical properties have been characterized by means of various molecular spectroscopic measurements. Furthermore, the photocatalytic reactivity for the decomposition of NO into  $N_2$ ,  $O_2$  and  $N_2O$  under UV light irradiation at 275 K has been investigated.

#### 2. Experimental

TiO<sub>2</sub> thin films were prepared by the ICB method [6–11] and a schematic diagram of the method is shown in figure 1. Titanium metal used as the source material was heated up to about 2200 K in the crucible and titanium vapor was introduced into the high vacuum chamber producing titanium clusters. At this time, the titanium clusters reacted with the O<sub>2</sub> molecules in the chamber and stoichiometric TiO<sub>2</sub> clusters were formed (oxygen pressure  $2 \times 10^{-4}$  Torr). Using electron beam irradiation, ionized TiO2 clusters were accelerated by an electric field (acceleration voltage 500 V) and bombarded onto the substrate. The temperature of the substrate was then heated up to 623 K to prepare a good crystallinity in the TiO<sub>2</sub> thin films. The resulting transparent TiO<sub>2</sub> thin films were then characterized by various spectroscopic means such as XRD and UV-VIS absorption measurements. The photocatalytic properties of these TiO<sub>2</sub> thin films were also investigated by carrying out the photocatalytic decomposition of NO under UV light ( $\lambda > 270$  nm) irradiation.

## 3. Results and discussion

Figure 2 shows the XRD patterns of the  $TiO_2$  thin films as well as powdered  $TiO_2$  (P-25) as reference. For the thin films in which the film thickness was smaller than 100 nm,

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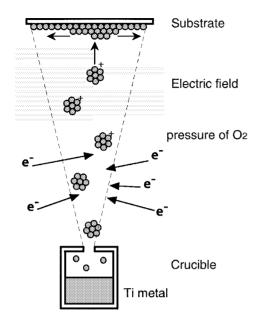


Figure 1. Schematic diagram of the ICB deposition method.

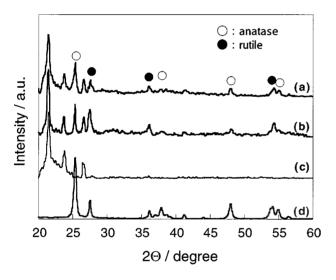


Figure 2. XRD patterns of  $TiO_2$  thin films prepared by an ICB method on porous Vycor glass (PVG).  $TiO_2$  thin films: (a) 500 and (b) 300 nm; (c) PVG (substrate) and (d)  $TiO_2$  (P-25) powder used as reference.

no peaks attributed to the  ${\rm TiO_2}$  structure could be detected and only peaks due to the  ${\rm SiO_2}$  substrate were observed. On the other hand, when the film thickness was larger than 300 nm, XRD patterns which could be attributed to the presence of an anatase and rutile structure of  ${\rm TiO_2}$  could be observed. Since the reference P-25 powdered  ${\rm TiO_2}$  (Degussa) is a composition of the anatase and rutile structure and exhibits high photocatalytic reactivity, it could be expected that  ${\rm TiO_2}$  thin film photocatalysts prepared by the ICB method would also exhibit high photocatalytic reactivity.

The UV-VIS absorption spectra of the  $TiO_2$  thin films are shown in figure 3. In these spectra,  $TiO_2$  thin films having a film thickness larger than 100 nm clearly show specific interference fringes, indicating that transparent and uniform  $TiO_2$  thin films were formed in these photocatalysts. As the film thickness decreases, the absorption spectra of the thin

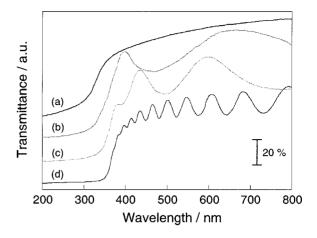


Figure 3. UV-VIS absorption spectra of  $TiO_2$  thin films prepared by an ICB method. Film thickness: (a) 20, (b) 100, (c) 300 and (d) 1000 nm.

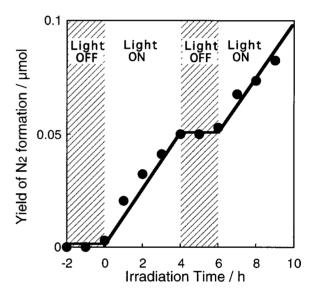


Figure 4. The reaction time profiles of the photocatalytic decomposition of NO on TiO<sub>2</sub> thin film (film thickness 100 nm) under UV light ( $\lambda$  > 270 nm) irradiation at 275 K.

films were found to shift toward shorter wavelength regions. This can be attributed to the quantum size effect of the thin films caused by the presence of  $TiO_2$  particles of small size as a composition of the transparent  $TiO_2$  thin films.

In the presence of NO, UV light ( $\lambda > 270$  nm) irradiation of TiO<sub>2</sub> thin film photocatalysts prepared by the ICB method led to the photocatalytic decomposition of NO into N<sub>2</sub>, O<sub>2</sub> and N<sub>2</sub>O at 275 K. Figure 4 shows the reaction time profiles of the photocatalytic decomposition of NO. The yield of the formation of N<sub>2</sub> (and O<sub>2</sub>) increases linearly with the UV irradiation time. The formation of these reaction products did not occur under dark conditions. Moreover, as shown in figure 4, as soon as UV irradiation was discontinued, the photocatalytic reaction immediately ceased. Thus, it was clearly shown that TiO<sub>2</sub> thin film photocatalysts prepared by the ICB method exhibit high photocatalytic reactivity for the direct decomposition of NO. The photocatalytic reactivity of these TiO<sub>2</sub> thin films was found to be comparable or even higher as compared with

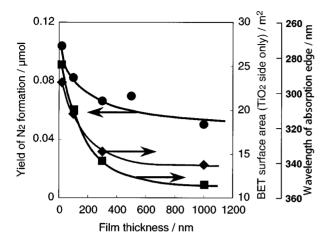


Figure 5. The effects of the film thickness on the photocatalytic reactivity of  $TiO_2$  photocatalysts for the decomposition of NO  $(\bullet)$  under UV light irradiation, the BET surface areas  $(\blacklozenge)$ , and the wavelength of absorption edge  $(\blacksquare)$ .

TiO<sub>2</sub> thin films prepared by the sol–gel method. It was also found that the photocatalytic reactivity strongly depends on the thickness of the films. Figure 5 shows the effect of the TiO<sub>2</sub> film thickness on the photocatalytic reactivity and the BET surface areas, as well as the wavelength of absorption edge of the thin film photocatalysts. TiO<sub>2</sub> thin films having small film thickness show much higher photocatalytic reactivity. As the film thickness increases, the photocatalytic reactivity becomes lower. The BET surface areas and the wavelength of the absorption edge show the same tendency towards the photocatalytic reactivity. These results clearly show that the photocatalytic properties of the TiO<sub>2</sub> thin films are dependent on the film thickness.

In summary, transparent  $TiO_2$  thin films were successfully prepared using an ICB method. Our  $TiO_2$  thin films worked efficiently and effectively as photocatalysts for the decomposition of NO into  $N_2$ ,  $O_2$  and  $N_2O$  under UV light irradiation at 275 K. The crystalline structure and electronic state of the  $TiO_2$  thin films varied along with their photocatalytic reactivity which strongly depended on the film thickness, i.e., as the film thickness decreases, the photocatalytic reactivity increases.

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